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EQUINOX 6000 4 circle texture/stress XRD

SWAXS SAXS WAXS instrumentation **PRECIX** XRD residual stress Robot

Portable Stress System Xsolo

Questions on which instrument is best suited for your application? Don't hesitate to contact us, our technical sales team will help configure a system for you.



Our technology to serve all your applications.

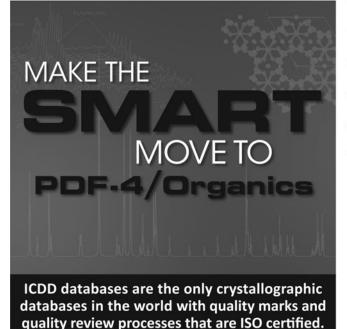
- PSD type detector for real time detection up to 120°/20
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PPXRD-14

Pharmaceutical Powder X-ray Diffraction Symposium XRD Training for the Pharmaceutical Scientist



Sanibel Harbour Marriott

Fort Myers, FL 6 – 9 June 2016

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SESSIONS...

- Patent Issues
- Amorphous, Activated, and Nano Materials
- Qualitative and Quantitative Analysis
- PXRD Techniques/Crystal Structure
 Prediction/Crystal Structure Verification
- New Frontiers in X-ray Diffraction for Pharmaceutical R&D
- Complementary Techniques/Formulation& Product Development

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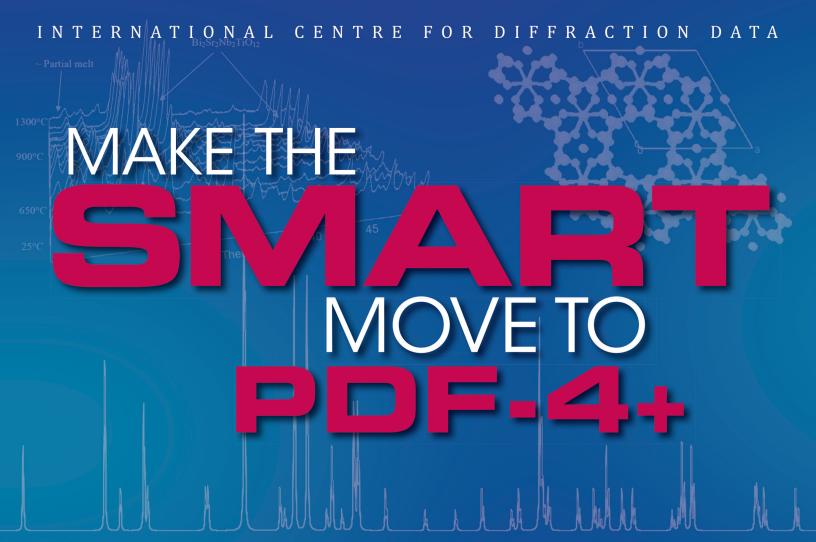




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